

Notice of References Cited	Application/Control No. 10/584,277	Applicant(s)/Patent Under Reexamination KOBAYASHI ET AL.	
	Examiner JACOB MARKS	Art Unit 1795	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0018425	01-2004	Kejha et al.	429/176
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	O	JP 07-094193	04-1995	Japan	Hikata	
	P					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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